



# On Uniformly Sampling Traces of a Transition System

#### Supratik Chakraborty, Aditya A. Shrotri, Moshe Y. Vardi

**ICCAD 2020** 

#### Speaker Bio

#### • Speaker: Aditya A. Shrotri

- Affiliation: Rice University, Houston TX
- PhD Student (Dept. of Computer Science)
- Adviser: Prof. Moshe Y. Vardi
- Thesis Area: Constrained Sampling and Counting
- Webpage: <u>https://cs.rice.edu/~as128</u>
- Co-Authors:
  - Prof. Supratik Chakraborty (IIT Bombay, India)
    - https://www.cse.iitb.ac.in/~supratik/





#### Prof. Moshe Y. Vardi (Rice University, Houston)

https://www.cs.rice.edu/~vardi/



### **Correctness of large designs**

- Enormous size and complexity of modern digital systems
  - Formal verification fails to scale
- Important to catch bugs early
  - Millions of dollars spent on faulty designs
- Constrained Random Verification balances scalability and coverage



#### **Constrained Random Verification**



Diagram courtesy www.testbench.in

- Constraints give direction
  - User-defined constraints steer to bug-prone corners
- Randomization enables diversity
  - Inputs sampled at specific simulation steps
- Widely used in industry
  - Ex: SystemVerilog, E, OpenVera etc.

#### Limitations of Existing CRV Tools

Provide 'local' uniformity over input stimuli

Insufficient for 'global' coverage guarantees

• Need uniformity of system's runs or traces

- **TraceSampler:** 1<sup>st</sup> dedicated algorithm + tool for uniformly sampling traces of a transition system
  - Uses Algebraic Decision Diagrams (ADDs) & enhanced iterative-squaring
  - Easily extensible to weighted sampling

- Empirical comparison to generic samplers based on SAT/CDCL
  - TraceSampler is fastest on ~90% of benchmarks
  - Solves 200 more benchmarks than nearest competitor

#### Outline

1. Example + problem definition

2. Inadequacy of Local Uniformity

3. Representing Large Transition Systems Compactly

4. TraceSampler: Two-Phase Algorithm

5. Experimental Results

#### Example: States, Traces and Uniformity



#### Example: States, Traces and Uniformity



Traces with N = 4 transitions (5 states):

- 1.  $S_0S_1S_1S_1S_1$
- $S_0 S_1 S_1 S_1 S_2 S_2$
- 3.  $S_0 S_1 S_1 S_2 S_2$
- 4.  $S_0S_1S_2S_2S_2$
- 5.  $S_0S_3S_1S_1S_1$
- 6.  $S_0 S_3 S_1 S_1 S_2$
- 7.  $S_0 S_3 S_1 S_2 S_2$

Uniformity: Sample each trace with probability 1/7

#### **Problem Definition**

- <u>Given:</u>
  - Transition System
  - Trace-length: N
  - (Optional) Initial States, Final States
- Let T be the set of traces of length N, which start in one of the initial states and end in one of the final states
- <u>Goal:</u>
  - Design algorithm that returns a trace  $T^*$ , such that

$$\forall T \in \mathbf{T} \quad \Pr[T^* = T] = \frac{1}{|\mathbf{T}|}$$



Current State: S<sub>0</sub>

Trace: S<sub>0</sub> Probability: 1

S <sub>3</sub>	0.5
<b>S</b> <sub>1</sub>	0.5



Current State: S<sub>0</sub>

Trace: S<sub>0</sub> S<sub>1</sub> Probability: 1\*0.5





Current State: S<sub>0</sub>

Trace:  $S_0 S_1 S_1$ Probability: 1\*0.5\*0.5





Current State: S<sub>0</sub>

Trace: S<sub>0</sub> S<sub>1</sub> S<sub>1</sub> S<sub>2</sub> Probability: 1\*0.5\*0.5\*0.5





Current State: S<sub>0</sub>

Trace:  $S_0 S_1 S_1 S_2 S_2$ Probability: 1\*0.5\*0.5\*0.5\*1 = 0.125





(b)

Current State: S<sub>0</sub>

Trace:  $S_0 S_1 S_1 S_2 S_2$ Probability: 1\*0.5\*0.5\*0.5\*1 = 0.125

**Fact:** Pr = 1/7 not possible for **any** assignment of local probabilities

#### **Representing the Transition Function**

- Transition graph typically very large
  - K latches  $\rightarrow$  2<sup>k</sup> states
  - Cannot represent explicitly
- Binary Decision Diagrams (BDDs) can offer significant compression

•Represent functions  $f: \{0,1\}^n \rightarrow \{0,1\}$ 

•DAGs with node sharing + fixed variable order



#### BDD Example



#### **Algebraic Decision Diagrams**

- Generalize BDDs to real-valued Boolean functions  $f: \{0,1\}^n \rightarrow R$ 
  - DAGs with fixed variable order and node-sharing
  - Operations: Sum, Product, Additive Quantification ( $\Sigma$ ), ITE







2-Step Transition Relation

#### TraceSampler: Two-Phase Algorithm

- Compilation Phase:
  - Construct  $\log N$  ADDs:  $t_1, t_2, t_4, t_8, \dots, t_N$  by iterative-squaring
    - Aggressively prune ADDs to avoid blowup

- Sampling Phase: Divide & Conquer
  - Recursively split trace while ensuring global uniformity
  - Base case: random walk on ADD from root to leaf

## **TraceSampler: ADD Compilation Phase**



- Secret Sauce: Aggressive pruning of ADDs by *novel i-step reachability algorithm*
- Advantages:
  - Only log(N) ADDs necessary:  $t_1$ ,  $t_2$ ,  $t_4$ ,  $t_8$ , ...,  $t_N$
  - Factored forms offer significant speedup & compression [Dudek et al.'20]

- Recursive Step
  - Sample state at half-way point then sample two halves independently

Trace Position	0	1	2	 N/4	 N/2	 3N/4	 N
State							

- Recursive Step
  - Sample state at half-way point then sample two halves independently



- Recursive Step
  - Sample state at half-way point then sample two halves independently



- Recursive Step
  - Sample state at half-way point then sample two halves independently

Trace Position	0	1	2		N/4		N/2	•••	3N/4		Ν
State	S <sub>0</sub>						S <sub>10</sub>				<b>S</b> <sub>5</sub>
$\log N - 1 ADD: t_{N/2}$											

- Recursive Step
  - Sample state at half-way point then sample two halves independently

Trace Position	0	1	2	•••	N/4	•••	N/2	•••	3N/4		Ν
State	S <sub>0</sub>				S <sub>11</sub>		S <sub>10</sub>		S <sub>8</sub>		<b>S</b> <sub>5</sub>
log N -1 ADD: <i>t<sub>N/2</sub></i>											

- Recursive Step
  - Sample state at half-way point then sample two halves independently

Trace Position	0	1	2		N/4		N/2	•••	3N/4		Ν
State	S <sub>0</sub>				S <sub>11</sub>		S <sub>10</sub>		S <sub>8</sub>		<b>S</b> <sub>5</sub>
log N -2 ADD: twu											

- Base case: sample states from ADD
  - Weighted random walk on ADD
  - Root to leaf traversal
    - Pick child C\* with probability  $Pr[C^*] = \frac{wt(C^*)}{\sum_i wt(C_i)}$
    - $wt(C^*) = \sum_{leaves} (num \ paths \ from \ C^* \ to \ leaf) \times val(leaf)$
    - Eg:  $wt(left child) = 2 \times 2 + 2 \times 1 = 6$



### **Empirical Evaluation: Uniformity**

- Sampled 10<sup>6</sup> traces from small benchmark
  - Using TraceSampler
  - Using Ideal Sampler (WAPS [Gupta et al.])
  - X-axis

•

- Count of how many times a particular trace was sampled
- Y-axis
  - Number of traces with specific count
- Distributions are indistinguishable
  - Jensen-Shannon distance: 0.003



#### **Empirical Evaluation: Scalability**

- Benchmarks: HWMCC'17, ISCAS89
- Trace Lengths: 2,4,8,16,...256
- Comparison: Encode circuits as CNF and unroll
  - WAPS: Exact uniform sampler [Gupta et al. '19]
  - Unigen2: Approximately uniform sampler
    - [Chakraborty et al. '15]

#### **Results**:

•

- TraceSampler solves 200+ more instances
- Fastest on ~90% instances
- Avg. Speedup: 3x to WAPS, 25x to Unigen2
- Compilation Speedup: 16x to WAPS



#### Summary and Takeaways

- TraceSampler: Novel ADD based algorithm for uniform / weighted sampling of traces
  - Significantly outperforms competing SAT/CDCL-based approaches
  - First prototype; more engineering effort → more scalability
  - Scope for heuristics and time-space tradeoffs

- Use synergistically with traditional CRV solutions?
  - Use CRV to reach bug-prone corner
  - Invoke TraceSampler for strong coverage guarantees

#### References

- [Dudek et al., '20] Jeffrey M Dudek, Vu HN Phan, and Moshe Y Vardi. AAAI 2020.
  ADDMC: Exact weighted model counting with algebraic decision diagrams
- [Gupta et al., 19] Rahul Gupta, Shubham Sharma, Subhajit Roy, and Kuldeep S Meel.
  2019. Waps: Weighted and projected sampling. In International Conference on Tools andAlgorithms for the Construction and Analysis of Systems. Springer, 59–76
- [Chakraborty et al., '15] Supratik Chakraborty, Daniel J Fremont, Kuldeep S Meel, Sanjit A Seshia, and Moshe Y Vardi. 2015. On parallel scalable uniform SAT witness generation. In International Conference on Tools and Algorithms for the Construction and Analysis of Systems. Springer, 304–319.